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UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of: SASHIDA, Naoya

Group Art Unit: 2811

Serial No.: 10/697,944

Examiner: Hoai V. PHAM

Filed: October 31, 2003

P.T.O. Confirmation No.: 8925

For:

SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING

THE SAME

INFORMATION DISCLOSURE STATEMENT **PURSUANT TO 37 CFR 1.97(b)**

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

November 15, 2005

Sir:

The attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached Form PTO-1449. One copy of each of these documents is attached.

No fee or certification is required in connection with this Information Disclosure Statement, since it is being submitted prior to the issuance of a first official action on the merits or expiration of the three month period following the filing date or the entry of the national stage of the abovecaptioned application.

The above information is presented so that the Patent and Trademark Office can, in the first instance, determine any materiality thereof to the claimed invention. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the documents cited in the attached Form PTO-1449 be made of record therein and appear on the first page of any patent to issue therefrom.





The Commissioner is authorized to charge our Deposit Account No. 01-2340 for any fee which is deemed by the Patent and Trademark Office to be required to effect consideration of this statement.

Respectfully submitted,

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PATENT TRADEMARK OFFICE

Enclosures: PTO-1449, References (8) and Partial European Search Report dated 10/24/05.

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INFORMATION DISCLOSURE CITATION PTO-1449

Atty. Docker No. 021557A	Serial No.	10/697,944

Applicant(s): SASHIDA, Naoya

Filing Date: October 31, 2003 Group Art Unit: 2811

U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
	AA	6,121,648	Evans, Jr.	9/19/00	257	295	
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FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Translation (Yes or No)
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OTHER DOCUMENTS

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	AK	DEC. 1999, PISCATAWAY, NJ, USA, IEEE, US, 5 December 1999 (1999-12-05), pages 801-804, XP010372095 ISBN: 0-7803-5410-9 *the whole document*. Partial European Search Report dated 10/24/05.
Examiner		Date Considered